

Improved Sample probe design for CETAC APS-1650 Automated Preparation Station

CETAC Automation introduces a new beveled-tip design stainless steel probe for the APS-1650 Automated Preparation Station.

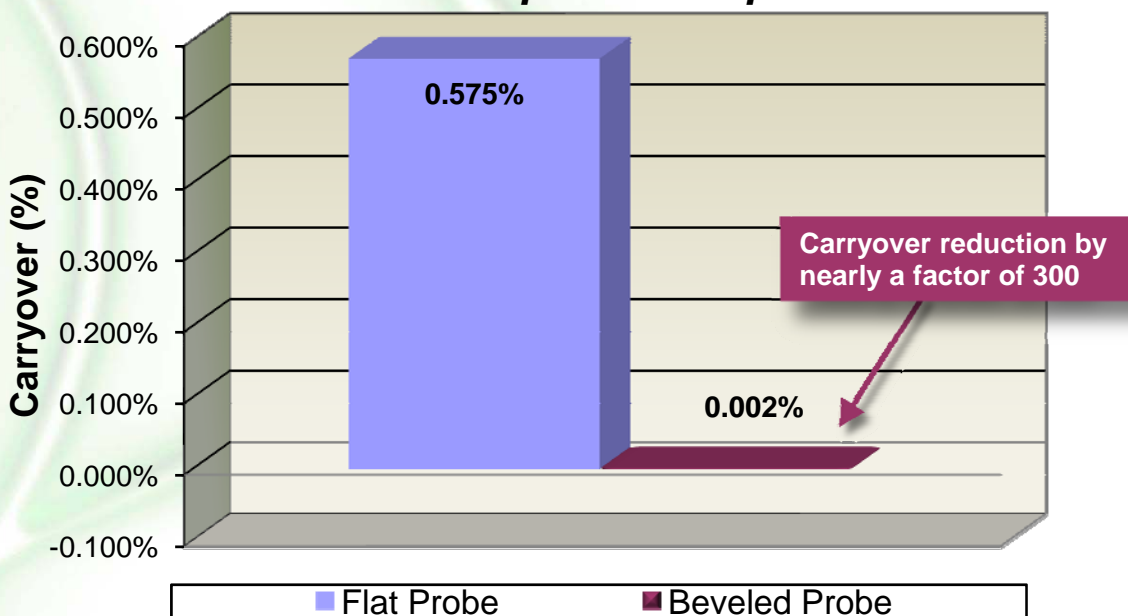
The beveled tip design creates turbulent flow inside the probe, which is more effective for rinsing out sample.

This reduces carryover to near zero levels without changing the current rinse settings or allows reducing rinse time and volume to achieve the same result.



Comparison of new beveled-tip probe (left) to the flat-tip probe.

CETAC APS-1650 Carryover Beveled-tip vs. Flat-tip Probe



*for more information on test data, visit www.cetac.com/automation

Ordering Information:

SP6261 Stainless steel, beveled-tip sample probe



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